### **DISCRETE SEMICONDUCTORS**

# DATA SHEET

# BF1101; BF1101R; BF1101WR N-channel dual-gate MOS-FETs

Product specification Supersedes data of 1999 Feb 01 1999 May 14



### N-channel dual-gate MOS-FETs

BF1101; BF1101R; BF1101WR

#### **FEATURES**

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier up to 1 GHz
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

#### **APPLICATIONS**

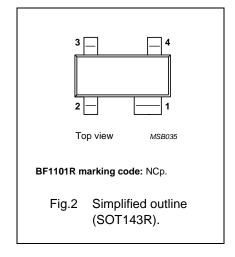
 VHF and UHF applications with 3 to 7 V supply voltage, such as television tuners and professional communications equipment.

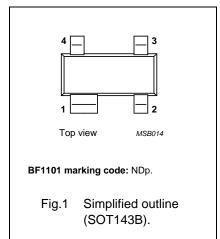
#### **DESCRIPTION**

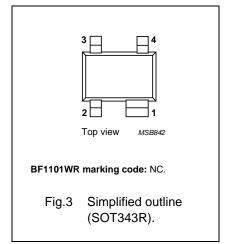
Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1101, BF1101R and BF1101WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

#### **PINNING**

| PIN | DESCRIPTION |
|-----|-------------|
| 1   | source      |
| 2   | drain       |
| 3   | gate 2      |
| 4   | gate 1      |







### **QUICK REFERENCE DATA**

| SYMBOL              | PARAMETER                      | CONDITIONS                          | MIN. | TYP. | MAX. | UNIT |
|---------------------|--------------------------------|-------------------------------------|------|------|------|------|
| V <sub>DS</sub>     | drain-source voltage           |                                     | _    | _    | 7    | V    |
| I <sub>D</sub>      | drain current                  |                                     | _    | _    | 30   | mA   |
| P <sub>tot</sub>    | total power dissipation        |                                     | _    | _    | 200  | mW   |
| y <sub>fs</sub>     | forward transfer admittance    |                                     | 25   | 30   | _    | mS   |
| C <sub>ig1-ss</sub> | input capacitance at gate 1    |                                     | -    | 2.2  | 2.7  | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance   | f = 1 MHz                           | _    | 25   | 35   | fF   |
| F                   | noise figure                   | f = 800 MHz                         | -    | 1.7  | 2.5  | dB   |
| X <sub>mod</sub>    | cross-modulation               | input level for k = 1% at 40 dB AGC | 100  | _    | _    | dBμV |
| Tj                  | operating junction temperature |                                     | _    | _    | 150  | °C   |

### **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

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### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

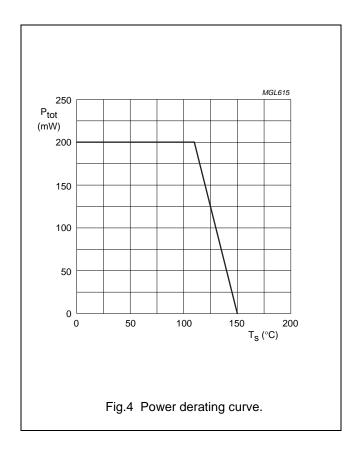
| SYMBOL           | PARAMETER                      | CONDITIONS                      | MIN. | MAX. | UNIT |
|------------------|--------------------------------|---------------------------------|------|------|------|
| $V_{DS}$         | drain-source voltage           |                                 | _    | 7    | V    |
| I <sub>D</sub>   | drain current                  |                                 | _    | 30   | mA   |
| I <sub>G1</sub>  | gate 1 current                 |                                 | _    | ±10  | mA   |
| I <sub>G2</sub>  | gate 2 current                 |                                 | _    | ±10  | mA   |
| P <sub>tot</sub> | total power dissipation        | T <sub>s</sub> ≤ 110 °C; note 1 | _    | 200  | mW   |
| T <sub>stg</sub> | storage temperature            |                                 | -65  | +150 | °C   |
| Tj               | operating junction temperature |                                 | _    | +150 | °C   |

### Note

1.  $T_s$  is the temperature of the soldering point of the source lead.

### THERMAL CHARACTERISTICS

| SYMBOL              | PARAMETER   | VALUE | UNIT |
|---------------------|---|-------|------|
| R <sub>th j-s</sub> | thermal resistance from junction to soldering point | 200   | K/W  |



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### STATIC CHARACTERISTICS

 $T_i = 25$  °C unless otherwise specified.

| SYMBOL                 | PARAMETER                       | CONDITIONS   | MIN. | MAX. | UNIT |
|------------------------|---------------------------------|--|------|------|------|
| V <sub>(BR)DSS</sub>   | drain-source breakdown voltage  | $V_{G1-S} = V_{G2-S} = 0; I_D = 10 \mu A$  | 7    | _    | V    |
| V <sub>(BR)G1-SS</sub> | gate 1-source breakdown voltage | $V_{G2-S} = V_{DS} = 0$ ; $I_{G1-S} = 10 \text{ mA}$                                 | 7    | 16   | V    |
| V <sub>(BR)G2-SS</sub> | gate 2-source breakdown voltage | $V_{G1-S} = V_{DS} = 0$ ; $I_{G2-S} = 10 \text{ mA}$                                 | 7    | 16   | V    |
| V <sub>(F)S-G1</sub>   | forward source-gate 1 voltage   | $V_{G2-S} = V_{DS} = 0; I_{S-G1} = 10 \text{ mA}$                                    | 0.5  | 1.5  | V    |
| V <sub>(F)S-G2</sub>   | forward source-gate 2 voltage   | $V_{G1-S} = V_{DS} = 0$ ; $I_{S-G2} = 10 \text{ mA}$                                 | 0.5  | 1.5  | V    |
| V <sub>G1-S (th)</sub> | gate 1-source threshold voltage | $V_{G2-S} = 4 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 100 \mu\text{A}$                | 0.3  | 1.0  | V    |
| V <sub>G2-S (th)</sub> | gate 2-source threshold voltage | $V_{G1-S} = 5 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 100 \mu\text{A}$                | 0.3  | 1.2  | V    |
| I <sub>DSX</sub>       | drain-source current            | $V_{G2-S} = 4 \text{ V}; V_{DS} = 5 \text{ V}; R_{G1} = 120 \text{ k}\Omega;$ note 1 | 8    | 16   | mA   |
| I <sub>G1-SS</sub>     | gate 1 cut-off current          | $V_{G2-S} = V_{DS} = 0; V_{G1-S} = 5 V$  | _    | 50   | nA   |
| I <sub>G2-SS</sub>     | gate 2 cut-off current          | V <sub>G1-S</sub> = V <sub>DS</sub> = 0; V <sub>G2-S</sub> = 4 V                     | _    | 20   | nA   |

#### Note

1.  $R_{G1}$  connects  $G_1$  to  $V_{GG} = 5$  V; see Fig.21.

### **DYNAMIC CHARACTERISTICS**

Common source;  $T_{amb} = 25$  °C;  $V_{G2-S} = 4$  V;  $V_{DS} = 5$  V;  $I_D = 12$  mA; unless otherwise specified.

| SYMBOL              | PARAMETER                    | CONDITIONS   | MIN. | TYP. | MAX. | UNIT |
|---------------------|------------------------------|--|------|------|------|------|
| y <sub>fs</sub>     | forward transfer admittance  | pulsed; T <sub>j</sub> = 25 °C   | 25   | 30   | 40   | mS   |
| C <sub>ig1-ss</sub> | input capacitance at gate 1  | f = 1 MHz  | _    | 2.2  | 2.7  | pF   |
| C <sub>ig2-ss</sub> | input capacitance at gate 2  | f = 1 MHz  | _    | 1.6  | _    | pF   |
| C <sub>oss</sub>    | output capacitance           | f = 1 MHz  | _    | 1.2  | _    | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance | f = 1 MHz  | _    | 25   | 35   | fF   |
| F                   | noise figure                 | $f = 800 \text{ MHz}; Y_S = Y_{S \text{ opt}}$   | _    | 1.7  | 2.5  | dB   |
| X <sub>mod</sub>    | cross-modulation             | input level for k = 1% at 0 dB AGC;<br>f <sub>w</sub> = 50 MHz; f <sub>unw</sub> = 60 MHz; note 1  | 85   | _    | _    | dBμV |
|                     |                              | input level for k = 1% at 40 dB AGC;<br>f <sub>w</sub> = 50 MHz; f <sub>unw</sub> = 60 MHz; note 1 | 100  | _    | _    | dBμV |

### Note

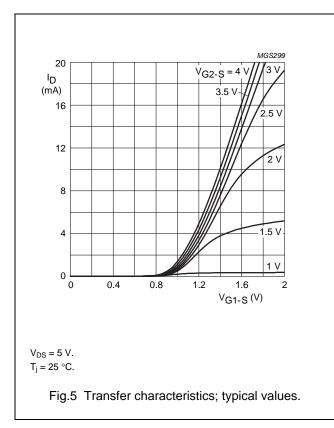
1. Measured in test circuit of Fig.21.

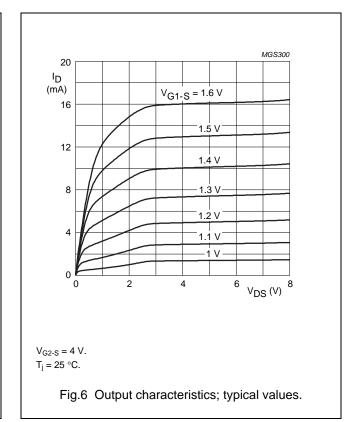
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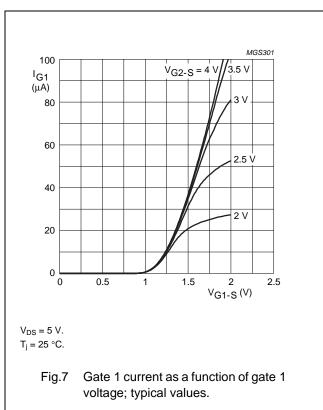
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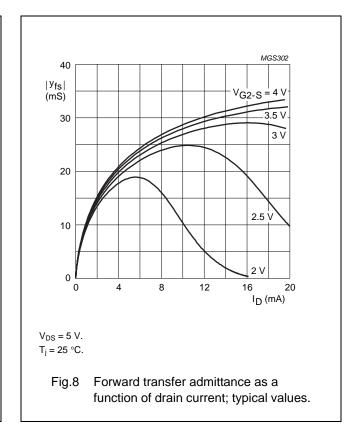
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### BF1101; BF1101R; BF1101WR









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### N-channel dual-gate MOS-FETs

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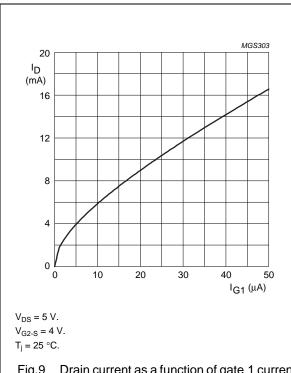
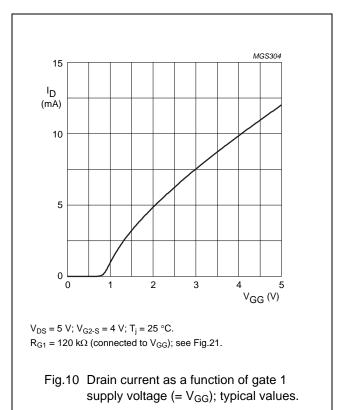
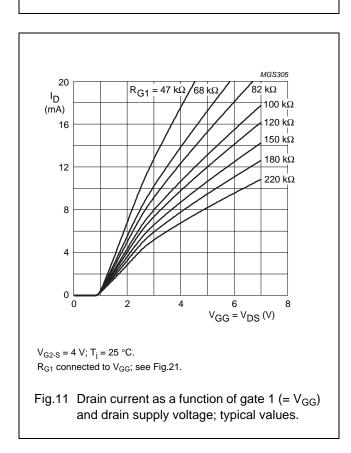
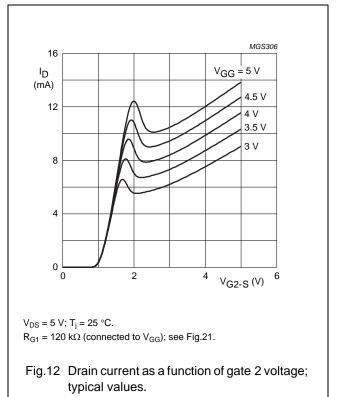


Fig.9 Drain current as a function of gate 1 current; typical values.

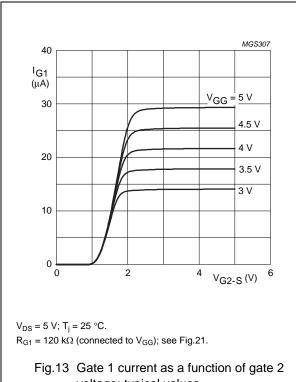




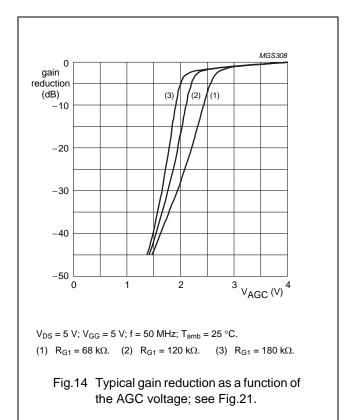


### N-channel dual-gate MOS-FETs

### BF1101; BF1101R; BF1101WR



voltage; typical values.



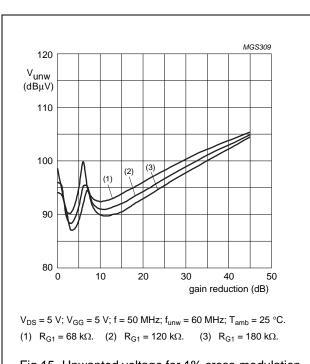
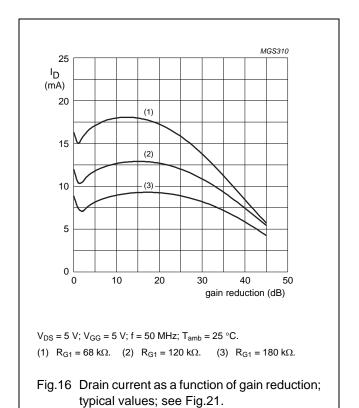


Fig.15 Unwanted voltage for 1% cross-modulation as a function of gain reduction; typical values; see Fig.21.



### N-channel dual-gate MOS-FETs

### BF1101; BF1101R; BF1101WR

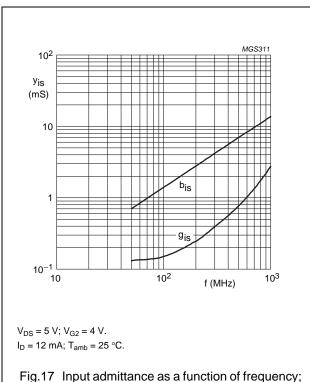


Fig.17 Input admittance as a function of frequency typical values.

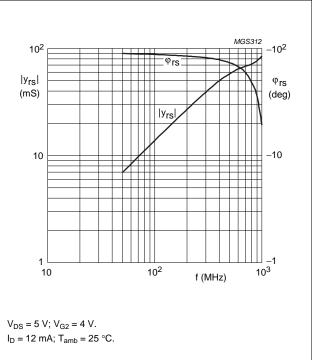
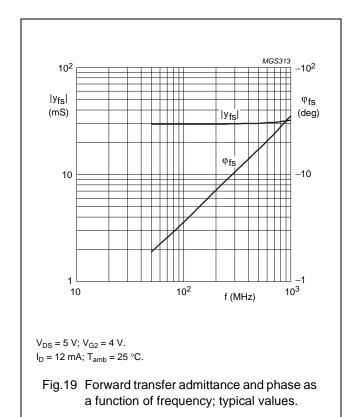
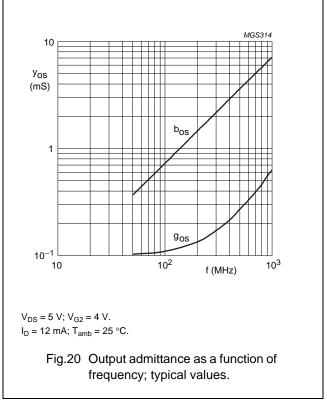


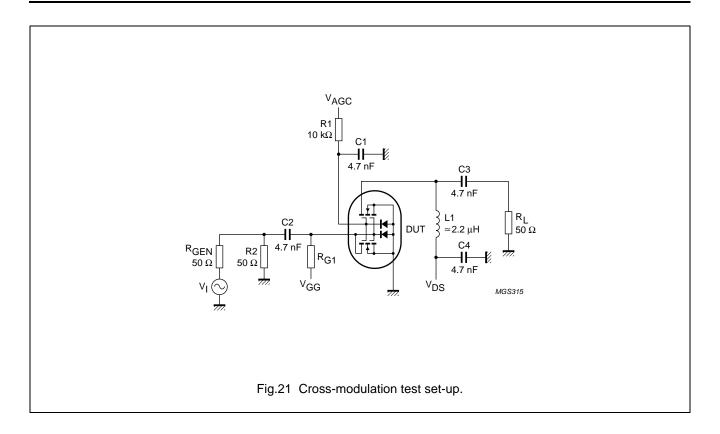
Fig.18 Reverse transfer admittance and phase as a function of frequency; typical values.





# N-channel dual-gate MOS-FETs

# BF1101; BF1101R; BF1101WR



**Table 1** Scattering parameters:  $V_{DS} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $I_D = 12 \text{ mA}$ ;  $T_{amb} = 25 ^{\circ}\text{C}$ 

| f     | S <sub>11</sub>   |                | S <sub>21</sub>   |             | S <sub>12</sub>   |                | S <sub>22</sub>   |             |
|-------|-------------------|----------------|-------------------|-------------|-------------------|----------------|-------------------|-------------|
| (MHz) | MAGNITUDE (ratio) | ANGLE<br>(deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE<br>(deg) | MAGNITUDE (ratio) | ANGLE (deg) |
| 50    | 0.987             | -4.1           | 2.922             | 175.0       | 0.001             | 87.6           | 0.990             | -2.2        |
| 100   | 0.985             | -8.1           | 2.908             | 170.3       | 0.001             | 86.1           | 0.989             | -4.3        |
| 200   | 0.976             | -16.1          | 2.875             | 160.8       | 0.003             | 83.3           | 0.985             | -8.5        |
| 300   | 0.963             | -23.9          | 2.820             | 157.6       | 0.004             | 80.4           | 0.982             | -12.6       |
| 400   | 0.949             | -31.6          | 2.762             | 142.6       | 0.005             | 78.2           | 0.977             | -16.8       |
| 500   | 0.933             | -38.8          | 2.665             | 134.1       | 0.005             | 77.8           | 0.972             | -20.8       |
| 600   | 0.916             | -45.7          | 2.591             | 125.7       | 0.005             | 78.9           | 0.967             | -24.7       |
| 700   | 0.897             | -52.2          | 2.498             | 117.7       | 0.006             | 81.8           | 0.961             | -28.5       |
| 800   | 0.877             | -58.4          | 2.410             | 109.6       | 0.005             | 89.1           | 0.957             | -32.2       |
| 900   | 0.856             | -64.5          | 2.318             | 101.6       | 0.006             | 97.1           | 0.950             | -35.8       |
| 1000  | 0.832             | -70.3          | 2.214             | 94.2        | 0.006             | 110.4          | 0.946             | -39.6       |

**Table 2** Noise data:  $V_{DS} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $I_D = 12 \text{ mA}$ ;  $T_{amb} = 25 ^{\circ}\text{C}$ 

| f     | F <sub>min</sub> | Γ       | opt   | R <sub>n</sub>      |
|-------|------------------|---------|-------|---------------------|
| (MHz) | (dB)             | (ratio) | (deg) | <b>(</b> Ω <b>)</b> |
| 800   | 1.5              | 0.715   | 58.3  | 37.85               |

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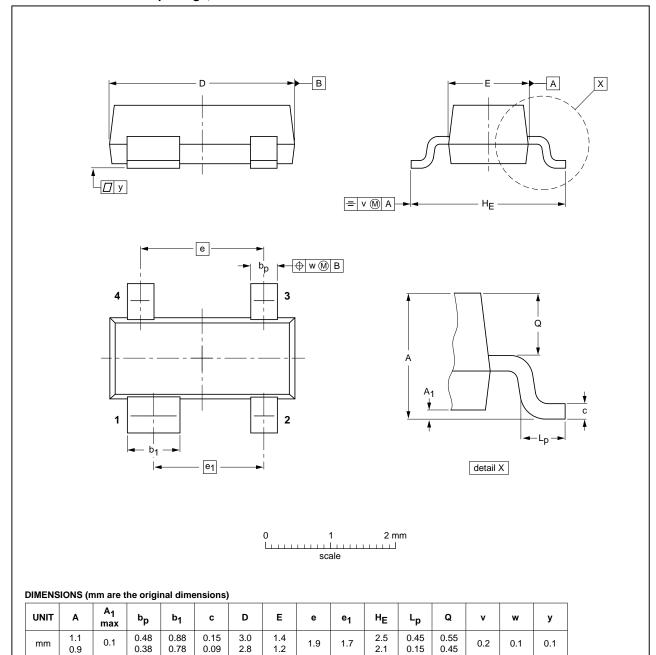
# N-channel dual-gate MOS-FETs

# BF1101; BF1101R; BF1101WR

### **PACKAGE OUTLINES**

Plastic surface-mounted package; 4 leads

SOT143B



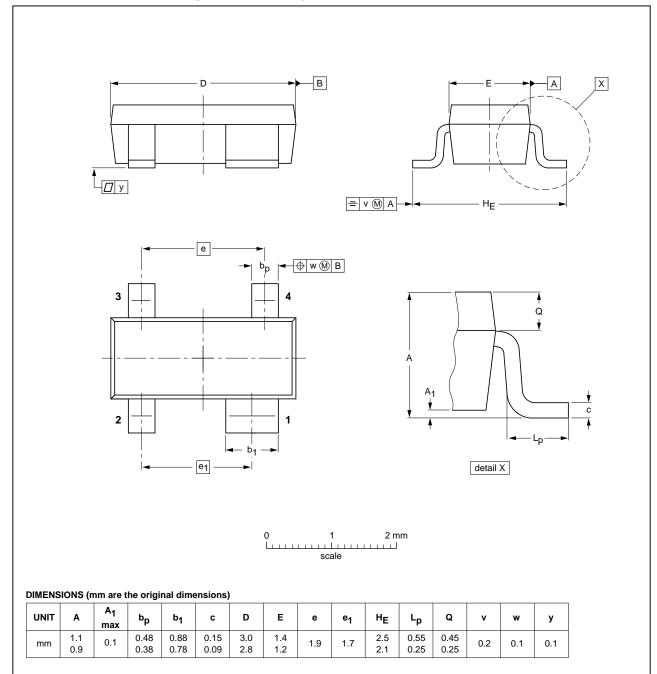
| OUTLINE | REFERENCES |       |       | EUROPEAN | ISSUE DATE                     |                                 |
|---------|------------|-------|-------|----------|--------------------------------|---------------------------------|
| VERSION | IEC        | JEDEC | JEITA |          | PROJECTION                     | ISSUE DATE                      |
| SOT143B |            |       |       |          | $ \  \   \bigoplus  \bigoplus$ | <del>04-11-16</del><br>06-03-16 |

# N-channel dual-gate MOS-FETs

# BF1101; BF1101R; BF1101WR

### Plastic surface-mounted package; reverse pinning; 4 leads

### SOT143R



| OUTLINE |     | REFERENCES |         |  |            | ISSUE DATE                        |
|---------|-----|------------|---------|--|------------|-----------------------------------|
| VERSION | IEC | JEDEC      | JEITA   |  | PROJECTION | ISSUE DATE                        |
| SOT143R |     |            | SC-61AA |  |            | <del>-04-11-16-</del><br>06-03-16 |

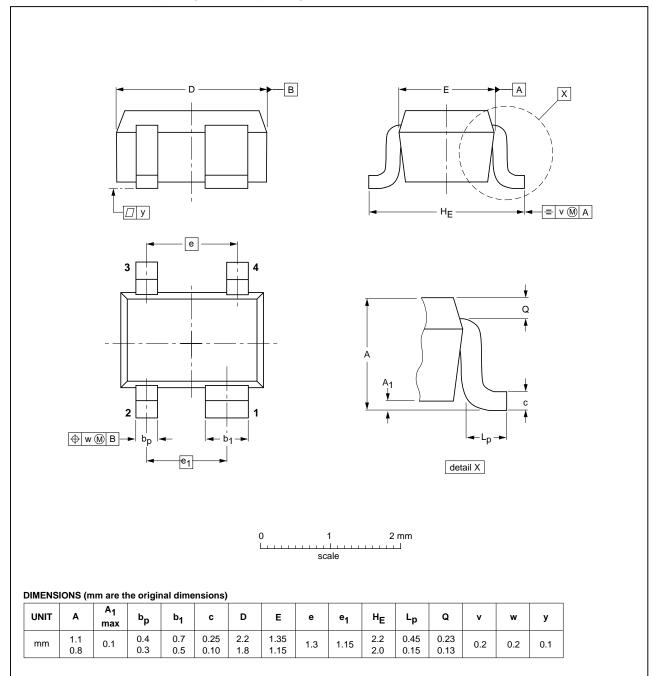
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# N-channel dual-gate MOS-FETs

# BF1101; BF1101R; BF1101WR

### Plastic surface-mounted package; reverse pinning; 4 leads

#### SOT343R



| OUTLINE | REFERENCES |       |      |  | EUROPEAN   | ISSUE DATE                      |
|---------|------------|-------|------|--|------------|---------------------------------|
| VERSION | IEC        | JEDEC | EIAJ |  | PROJECTION | ISSUE DATE                      |
| SOT343R |            |       |      |  |            | <del>97-05-21</del><br>06-03-16 |

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### N-channel dual-gate MOS-FETs

BF1101; BF1101R; BF1101WR

#### **DATA SHEET STATUS**

| DOCUMENT<br>STATUS <sup>(1)</sup> | PRODUCT<br>STATUS <sup>(2)</sup> | DEFINITION  |
|-----------------------------------|----------------------------------|---|
| Objective data sheet              | Development                      | This document contains data from the objective specification for product development. |
| Preliminary data sheet            | Qualification                    | This document contains data from the preliminary specification.                       |
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